Substitute Form PTO-1449  
(Modified)U.S. Department of Commerce  
Patent and Trademark OfficeAttorney's Docket No.  
08935-302001Application No.  
10/765,569
**Information Disclosure Statement  
by Applicant**  
 (Use several sheets if necessary)
Applicant  
Nikolay K. Iltchev et al.Filing Date  
January 28, 2004Group Art Unit  
Unknown**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/LW/	AA	5,599,644	02/04/1997	Swierbut et al.			
/LW/	AB	5,698,315	12/16/1997	Hayashi et al.			
/LW/	AC	5,919,518	07/06/1999	Hayashi et al.			
/LW/	AD	5,997,775	12/07/1999	Hayashi et al.			
/LW/	AE	6,203,943	03/20/2001	Bennett et al.			
/LW/	AF	6,337,160	01/08/2002	Hilarius et al.			
/LW/	AG	6,348,259	02/19/2002	Hilarius et al.			
	AH						
	AI						
	AJ						
	AK						

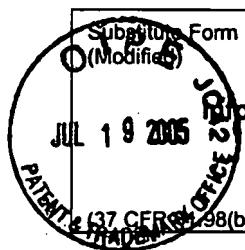
**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/LW/	AL	WO93/12551	24.06.93	PCT				
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature /Laura Weiner/	Date Considered 04/29/2007
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1745**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/LW/	AA	5,156,934	10/20/92	Kainthia et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/LW/	AL	WO 00/30198	05/25/00	PCT				
/LW/	AM	DE 196 07 512 A1	11/13/97	Germany				X
/LW/	AN	05-2225978	09/03/93	Japan (English Abstract Only)				
	AO							
	AP							

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